

## AON6232

## 40V N-Channel MOSFET

## **General Description**

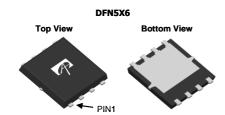
The AON6232 uses trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Power losses are minimized due to an extremely low combination of  $R_{\text{DS(ON)}}$  and Crss. In addition, switching behavior is well controlled with a "Schottky style" soft recovery body diode.

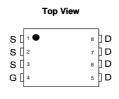
## **Product Summary**

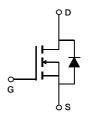
 $\begin{array}{lll} V_{DS} & 40V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 85A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 2.5 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 3.6 m\Omega \end{array}$ 

100% UIS Tested 100% R<sub>g</sub> Tested









Absolute Maximum Ratings T <sub>A</sub> =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V <sub>DS</sub>	40	V			
Gate-Source Voltage		V <sub>GS</sub>	±20	V			
Continuous Drain	T <sub>C</sub> =25℃		85				
Current <sup>G</sup>	T <sub>C</sub> =100℃	I <sub>D</sub>	67	A			
Pulsed Drain Current <sup>c</sup>		I <sub>DM</sub>	260				
Continuous Drain Current	T <sub>A</sub> =25℃		22	Δ.			
	T <sub>A</sub> =70℃	IDSM	17	Α			
Avalanche Current <sup>C</sup>		I <sub>AS</sub> , I <sub>AR</sub>	60	A			
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub> , E <sub>AR</sub>	180	mJ			
	T <sub>C</sub> =25℃	P <sub>D</sub>	83	W			
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100℃	- P	33	VV			
	T <sub>A</sub> =25℃	D	2.3	W			
Power Dissipation A	T <sub>A</sub> =70℃	P <sub>DSM</sub>	1.4	VV			
Junction and Storage Temperature Range		$T_J$ , $T_{STG}$	-55 to 150	C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	14	17	℃/W			
Maximum Junction-to-Ambient AD	Steady-State $R_{\theta JA}$		40	55	°C/W			
Maximum Junction-to-Case Steady-		$R_{\theta JC}$	1.1	1.5	℃/W			



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Parameter Conditions		Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V$	40			V				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V			1	μА				
	Zero date voltage Brain durrent	T <sub>J</sub> =55℃			5	μΑ				
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V			100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	1.3	1.8	2.3	V				
$I_{D(ON)}$	On state drain current	V <sub>GS</sub> =10V, V <sub>DS</sub> =5V	260			Α				
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A		2.05	2.5	mΩ				
		T <sub>J</sub> =125℃		3.2	3.9	11152				
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A		2.8	3.6	mΩ				
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_{D}$ =20A		100		S				
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.68	1	V				
Is	Maximum Body-Diode Continuous Curr			85	Α					
DYNAMIC	PARAMETERS									
C <sub>iss</sub>	Input Capacitance		2530	3165	3800	pF				
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =20V, f=1MHz	630	905	1180	pF				
C <sub>rss</sub>	Reverse Transfer Capacitance		15	52.5	90	pF				
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	0.4	0.85	1.3	Ω				
SWITCHI	NG PARAMETERS									
Q <sub>g</sub> (10V)	Total Gate Charge		33	42	51	nC				
Q <sub>g</sub> (4.5V)	Total Gate Charge	V -10V V -20V I -20A	12	18.2	24	nC				
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =10V, $V_{DS}$ =20V, $I_{D}$ =20A		9.6		nC				
$Q_{gd}$	Gate Drain Charge	1		2.8		nC				
t <sub>D(on)</sub>	Turn-On DelayTime			8.7		ns				
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =20V, $R_L$ =1 $\Omega$ ,		4.5		ns				
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}=3\Omega$		33.5		ns				
t <sub>f</sub>	Turn-Off Fall Time	]		6.2		ns				
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=500A/μs	15	22.5	30	ns				
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, dI/dt=500A/μs	41	59	77	nC				

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation  $P_{DSM}$  is based on R  $_{\theta JA}$  and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

- D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial  $T_J$ =25° C.

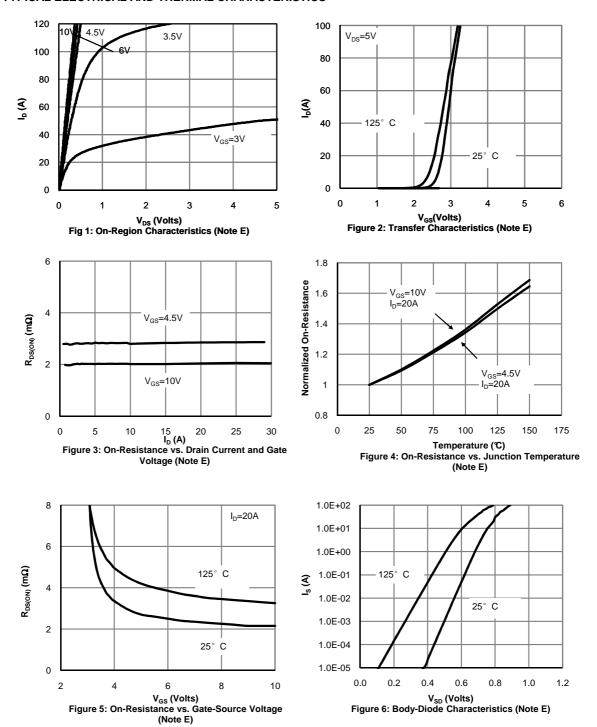
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25° C.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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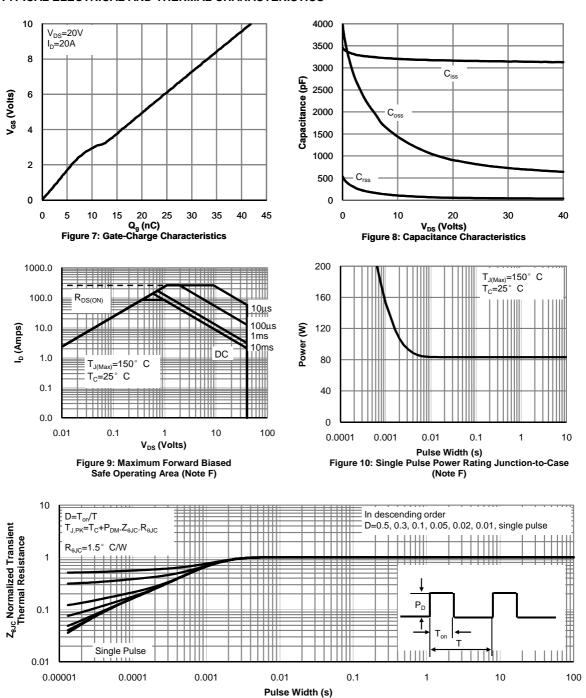
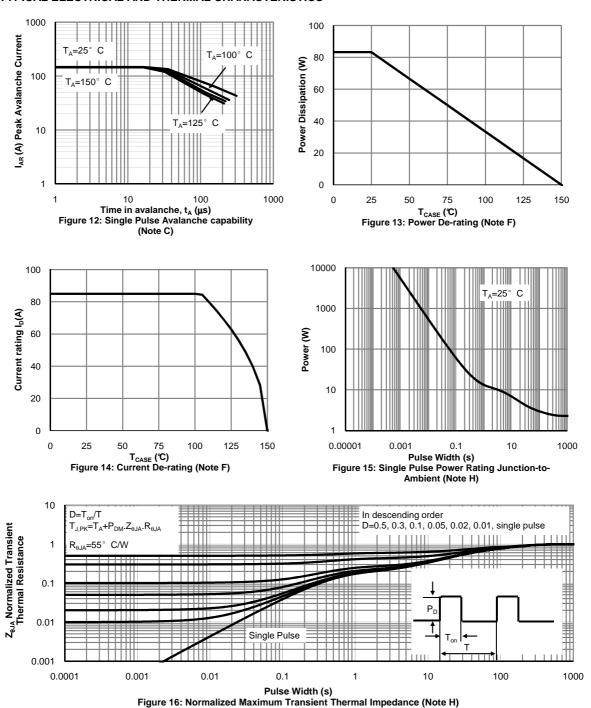


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

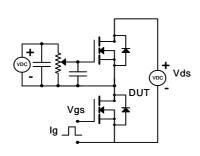


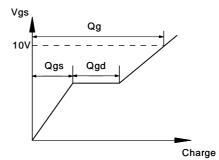
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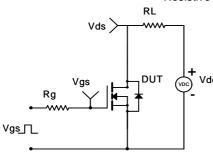


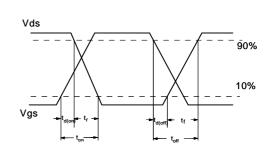
## Gate Charge Test Circuit & Waveform



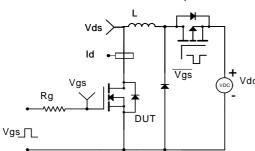


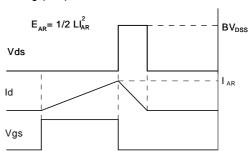
## Resistive Switching Test Circuit & Waveforms



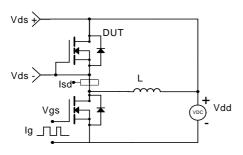


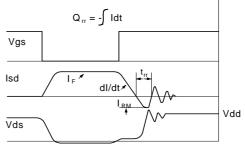
## Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms





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